Application/Control No. Applicant(s)/Patent Under Reexamination 10/661,116 PUTNAM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Arnel C. Lavarias 2872 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α В US-С US-D US-Ε US-F US-US-G Н US-1 US-US-J Κ US-US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP11119029A1 Ν 04-1999 Japan Terao G02B006/00 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U NONE W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х